

# **MOSFET** – N-Channel, SuperFET®

600 V, 20 A, 190 mΩ

## **FCP20N60, FCPF20N60**

#### **Description**

SuperFET MOSFET is **onsemi**'s first generation of high voltage super–junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low onresistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.

#### **Features**

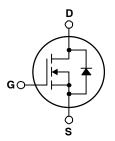
- 650 V @  $T_I = 150$  °C
- Typ.  $R_{DS(on)} = 150 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 75 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 165 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

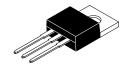
- Solar Inverter
- AC DC Power Supply

V <sub>DS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
600 V	190 mΩ @ 10 V	20 A*

<sup>\*</sup>Drain current limited by maximum junction temperature.



**N-CHANNEL MOSFET** 

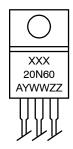


TO-220-3LD CASE 340AT



TO-220 Fullpack, 3-Lead / TO-220F-3SG CASE 221AT

#### **MARKING DIAGRAM**



XXX20N60 = Device Code (XXX = FCP, FCPF)

A = Assembly Location YWW = Date Code (Year & Week)

ZZ = Assembly Lot

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#### **ORDERING INFORMATION**

Device	Package	Shipping
FCP20N60	TO-220	1000 Units / Tube
FCPF20N60	TO-220F	1000 Units / Tube

#### **MOSFET MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter FCP20N60 FCPF20N60		FCPF20N60	Unit	
V <sub>DSS</sub>	Drain-Source Voltage		6	600	
I <sub>D</sub>	Drain Current	− Continuous, T <sub>C</sub> = 25°C	20	20*	Α
		− Continuous, T <sub>C</sub> = 100°C	12.5	12.5*	
I <sub>DM</sub>		- Pulsed (Note 1)	60	60*	
V <sub>GSS</sub>	Drain-Source Voltage	•	±	±30	
E <sub>AS</sub>	Single Pulsed Avalanc	he Energy (Note 2)	690		mJ
I <sub>AR</sub>	Avalanche Current (No	ote 1)	:	20	
E <sub>AR</sub>	Repetitive Avalanche E	Energy (Note 1)	20.8		mJ
dv/dt	Peak Diode Recovery	dv/dt (Note 3)	4	4.5	
$P_{D}$	Power Dissipation	T <sub>C</sub> = 25°C	208	39	W
		−Derate above = 25°C	1.67	0.3	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage	Temperature Range	–55 t	-55 to +150	
TL	Maximum Lead Tempe 1/8" from Case for 5 Se		300		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
\*Drain current limited by maximum junction temperature.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	FCP20N60	FCPF20N60	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	0.6	3.2	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

<sup>1.</sup> Repetitive rating: pulse–width limited by maximum junction temperature. 2.  $I_{AS} = 10 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$ ,  $R_{G} = 25 \Omega$ , starting  $T_{J} = 25^{\circ}\text{C}$ . 3.  $I_{SD} \leq 20 \text{ A}$ , di/dt  $\leq 200 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , starting  $T_{J} = 25^{\circ}\text{C}$ .

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS		•		-	
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_J = 25^{\circ}C$	600	_	_	V
		$I_D = 250 \mu A, V_{GS} = 0 V, T_J = 150^{\circ} C$	_	650	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	0.6	-	V/°C
BV <sub>DS</sub>	Drain-Source Avalanche Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 20 A	-	700	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C	_	-	10	
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V	_	-	±100	μΑ
ON CHARA	CTERISTICS		•	•		•
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A	-	0.15	0.19	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 10 A	_	17	-	S
DYNAMIC (	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	2370	3080	pF
C <sub>oss</sub>	Output Capacitance	]	-	1280	1665	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]	-	95	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	65	85	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 400 V, V <sub>GS</sub> = 0 V	-	165	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10 V	$V_{DS} = 480 \text{ V}, I_{D} = 20 \text{ A},$	-	75	98	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	V <sub>GS</sub> = 10 V (Note 4)	-	13.5	18	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	]	-	36	-	nC
SWITCHING	G CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 300 \text{ V}, I_D = 20 \text{ A},$	_	62	135	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{G} = 25 \Omega \text{ (Note 4)}$	-	140	290	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	]	-	230	470	ns
t <sub>f</sub>	Turn-Off Fall Time	1	-	65	140	ns
DRAIN-SO	URCE DIODE CHARACTERISTICS					
Is	Maximum Continuous Drain to Source Diode Forward Current		-	_	20	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		_	-	60	Α
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 20 A	_	_	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 20 A,	_	530	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt = 100 A/μs	-	10.5	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

#### TYPICAL PERFORMANCE CHARACTERISTICS

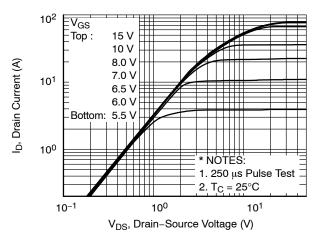


Figure 1. On-Region Characteristics

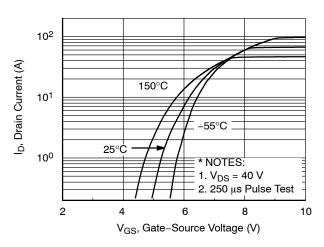


Figure 2. Transfer Characteristics

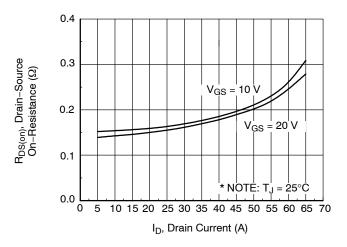


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

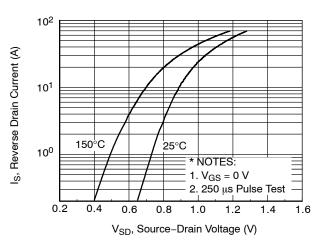


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

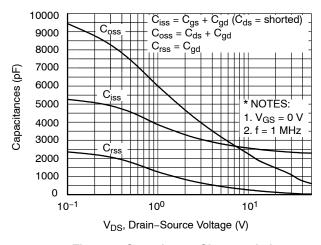


Figure 5. Capacitance Characteristics

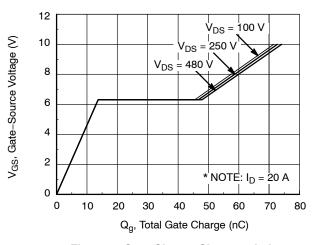


Figure 6. Gate Charge Characteristics

#### TYPICAL PERFORMANCE CHARACTERISTICS (continued)

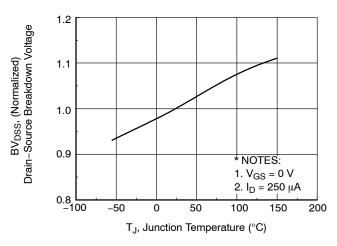


Figure 7. Breakdown Voltage Variation vs. Temperature

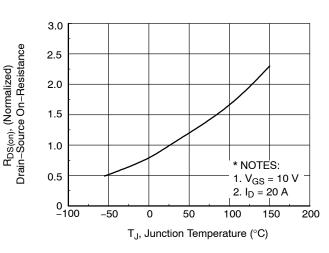


Figure 8. On-Resistance Variation vs. Temperature

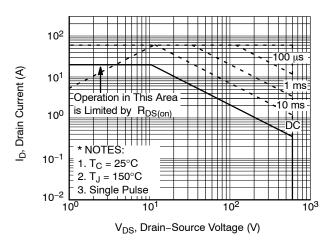


Figure 9. Maximum Safe Operating
Area for FCP20N60

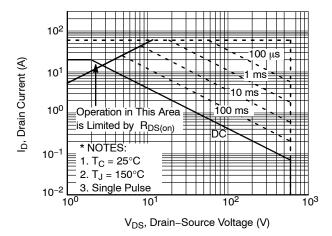


Figure 10. Maximum Safe Operating
Area for FCPF20N60

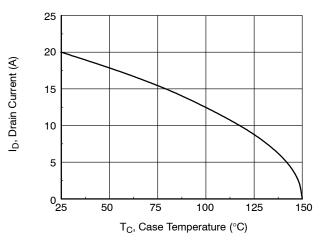


Figure 11. Maximum Drain Current vs. Case Temperature

#### TYPICAL PERFORMANCE CHARACTERISTICS (continued)

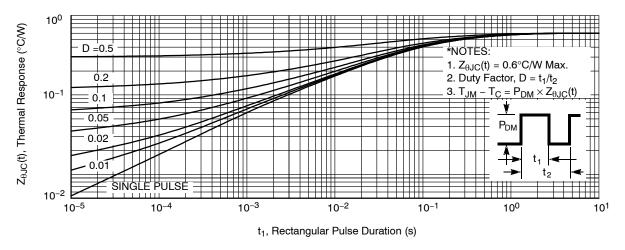


Figure 12. Transient Thermal Response Curve for FCP20N60

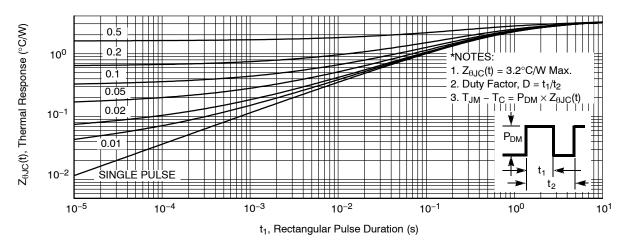


Figure 13. Transient Thermal Response Curve for FCPF20N60

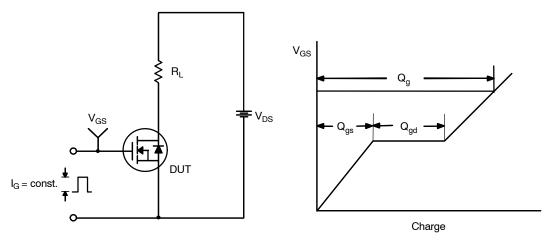


Figure 14. Gate Charge Test Circuit & Waveform

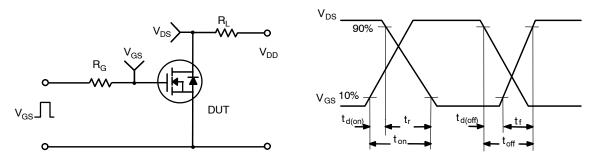


Figure 15. Resistive Switching Test Circuit & Waveforms

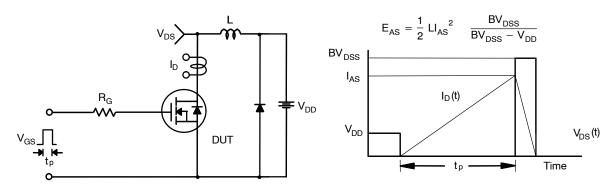


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

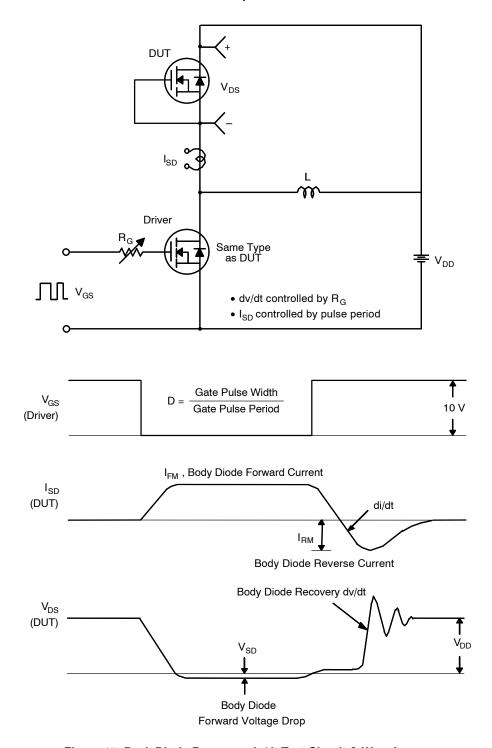
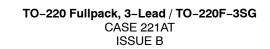
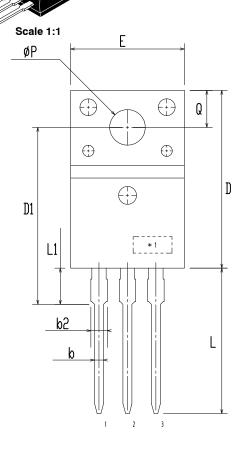


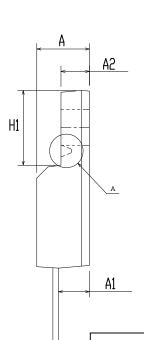
Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

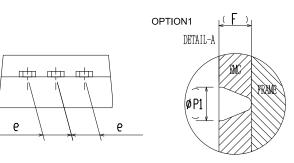
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**DATE 19 JAN 2021** 







DIM	MIL	LIMITERS	
DIM	MIN	NDM	MAX
Α	4.50	4.70	4.90
A1	2.56	2.76	2.96
A2	2.34	2.54	2.74
b	0.70	0.80	0.90
b2	*	2	1.47
C	0.45	0.50	0.60
D	15.67	15.87	16.07
D1	15.60	15.80	16.00
E	9.96	10.16	10.36
е	2.34	2.54	2.74
F	~	0.84	~
H1	6.48	6.68	6.88
Ш	12.78	12.98	13.18
L1	3.03	3.23	3.43
ØΡ	2.98	3.18	3.38
Ø P1	~	1.00	~
Q	3.20	3.30	3.40

#### NOTES:

- A. DIMENSION AND TOLERANCE AS ASME Y14.5-2009
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUCSIONS.

C

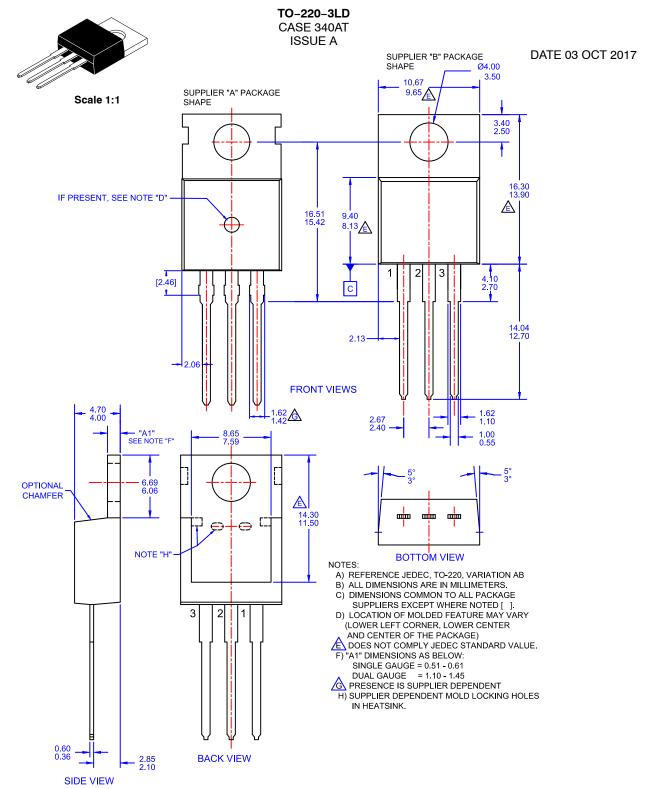
C. OPTION 1 - WITH SUPPORT PIN HOLE

OPTION 2 - NO SUPPORT PIN HOLE

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